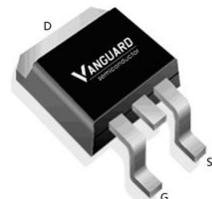


Features

- Enhancement mode
- Very low on-resistance $R_{DS(on)}$ @ $V_{GS}=10V$
- Fast Switching and High efficiency
- 100% Avalanche Tested
- Pb-free lead plating; RoHS compliant

V_{DS}	100	V
$R_{DS(on),TYP} @ V_{GS}=10V$	4.2	$m\Omega$
I_D	200	A

TO-263

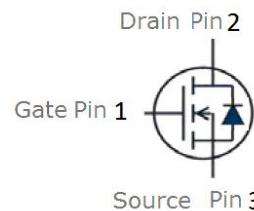


RoHS



Halogen-Free

Part ID	Package Type	Marking	Tape and reel information
VS4110ATD	TO-263	4110ATD	1000pcs/Reel



Maximum ratings, at $T_A=25^{\circ}\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	100	V
V_{GS}	Gate-Source voltage	± 25	V
I_S	Diode continuous forward current	$T_C=25^{\circ}\text{C}$	A
I_D	Continuous drain current @ $V_{GS}=10V$	$T_C=25^{\circ}\text{C}$	A
		$T_C=100^{\circ}\text{C}$	A
I_{DM}	Pulse drain current tested ①	$T_C=25^{\circ}\text{C}$	A
I_{DSM}	Continuous drain current @ $V_{GS}=10V$	$T_A=25^{\circ}\text{C}$	A
		$T_A=70^{\circ}\text{C}$	A
EAS	Avalanche energy, single pulsed ②	900	mJ
P_D	Maximum power dissipation	$T_C=25^{\circ}\text{C}$	W
		$T_C=100^{\circ}\text{C}$	W
P_{DSM}	Maximum power dissipation ③	$T_A=25^{\circ}\text{C}$	W
		$T_A=70^{\circ}\text{C}$	W
T_{STG}, T_J	Storage and Junction Temperature Range	-55 to 175	$^{\circ}\text{C}$

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.4	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	$^{\circ}\text{C}/\text{W}$



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VS4110ATD

100V/200A N-Channel Advanced Power MOSFET

Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	100	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current($T_j=25^\circ\text{C}$)	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	μA
	Zero Gate Voltage Drain Current($T_j=125^\circ\text{C}$)	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 25\text{V}, V_{\text{DS}}=0\text{V}$	--	--	± 100	nA
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.5	3	3.5	V
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance ④	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=40\text{A}$	--	4.2	5.5	$\text{m}\Omega$
		$T_j=100^\circ\text{C}$	--	5.6	--	$\text{m}\Omega$

Dynamic Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)

C_{iss}	Input Capacitance	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	7410	8715	10020	pF
C_{oss}	Output Capacitance		685	805	925	pF
C_{rss}	Reverse Transfer Capacitance		530	620	710	pF
R_g	Gate Resistance	$f=1\text{MHz}$	--	1.6	--	Ω
Q_g	Total Gate Charge	$V_{\text{DS}}=50\text{V}, I_{\text{D}}=40\text{A}, V_{\text{GS}}=10\text{V}$	--	172	--	nC
	Gate-Source Charge		--	36	--	nC
	Gate-Drain Charge		--	62	--	nC

Switching Characteristics

$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=50\text{V}, I_{\text{D}}=40\text{A}, R_{\text{G}}=3\Omega, V_{\text{GS}}=10\text{V}$	--	26	--	ns
t_r	Turn-on Rise Time		--	66	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	95	--	ns
t_f	Turn-Off Fall Time		--	66	--	ns

Source- Drain Diode Characteristics@ $T_j = 25^\circ\text{C}$ (unless otherwise stated)

V_{SD}	Forward on voltage	$I_{\text{SD}}=40\text{A}, V_{\text{GS}}=0\text{V}$	--	0.8	1.2	V
t_{rr}	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{SD}}=40\text{A}, V_{\text{GS}}=0\text{V}$	--	52	--	ns
			--	114	--	nC

NOTE: ① Repetitive rating; pulse width limited by max junction temperature.

② Limited by $T_{j\text{max}}$, starting $T_j = 25^\circ\text{C}$, $L = 0.5\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 60\text{A}$, $V_{GS} = 10\text{V}$. Part not recommended for use above this value

③ The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C .

④ Pulse width $\leq 380\mu\text{s}$; duty cycles $\leq 2\%$.



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VS4110ATD

100V/200A N-Channel Advanced Power MOSFET

Typical Characteristics

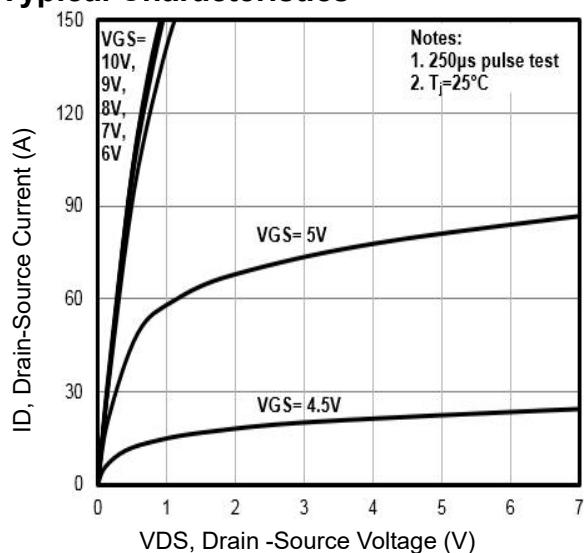


Fig1. Typical Output Characteristics

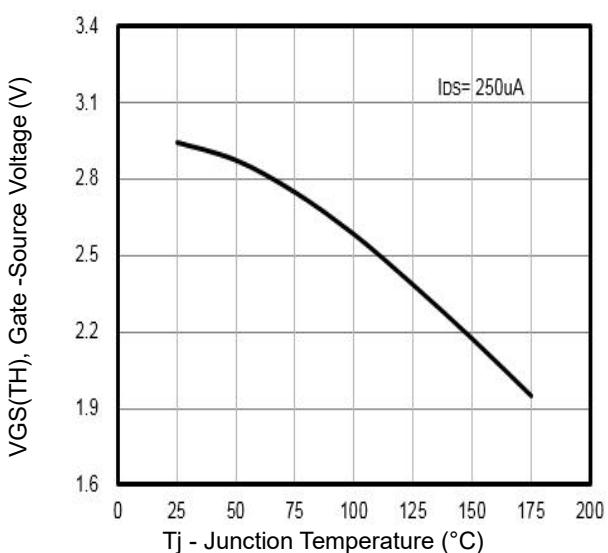


Fig2. $VGS(TH)$ Gate -Source Voltage Vs. T_j

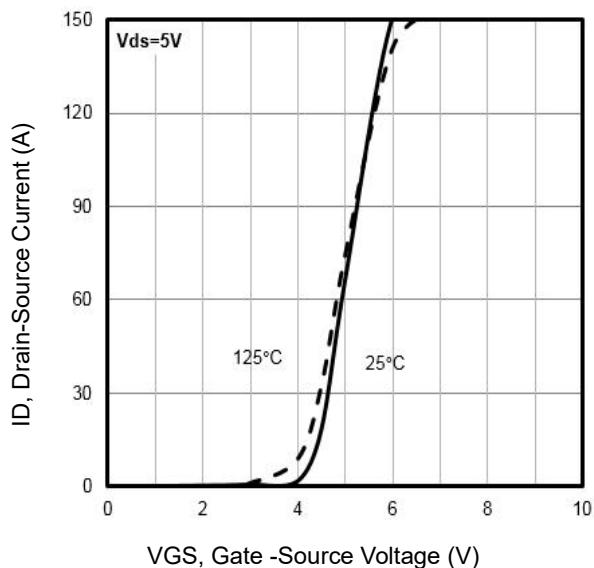


Fig3. Typical Transfer Characteristics

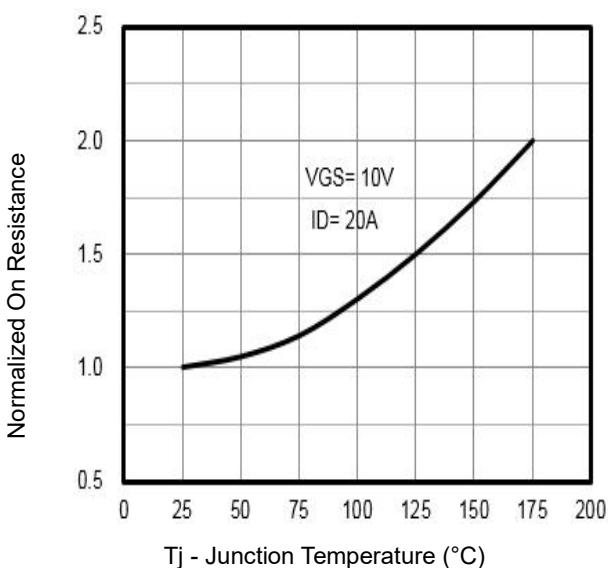


Fig4. Normalized On-Resistance Vs. Temperature

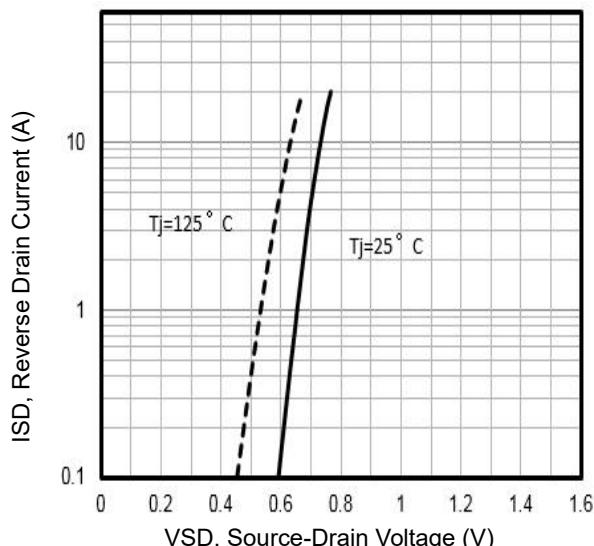


Fig5. Typical Source-Drain Diode Forward Voltage

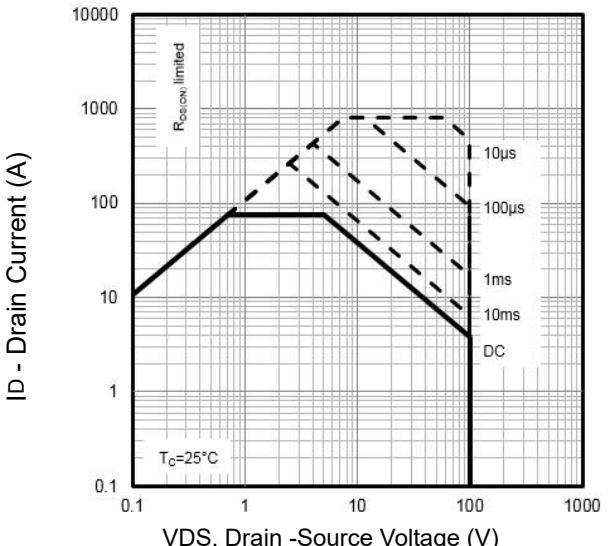


Fig6. Maximum Safe Operating Area



Typical Characteristics

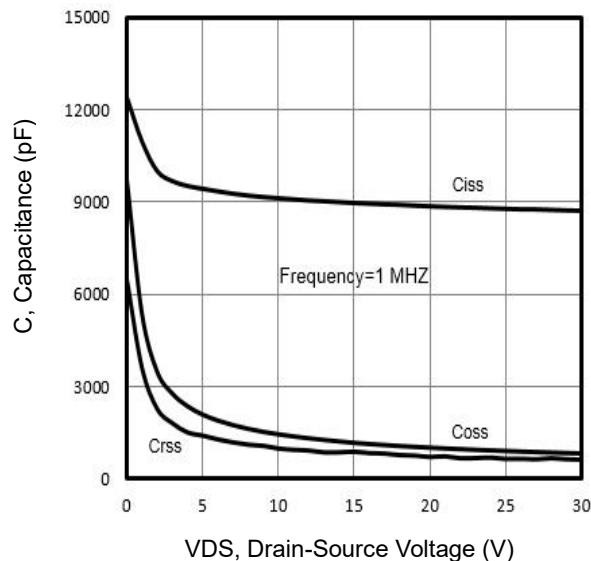


Fig7. Typical Capacitance Vs. Drain-Source Voltage

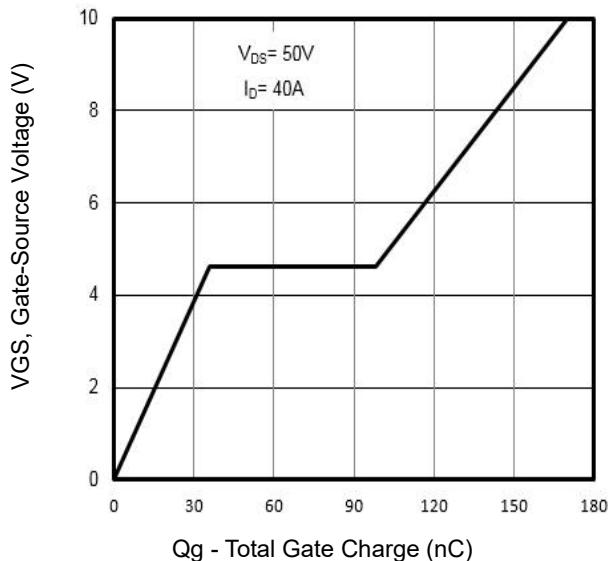


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

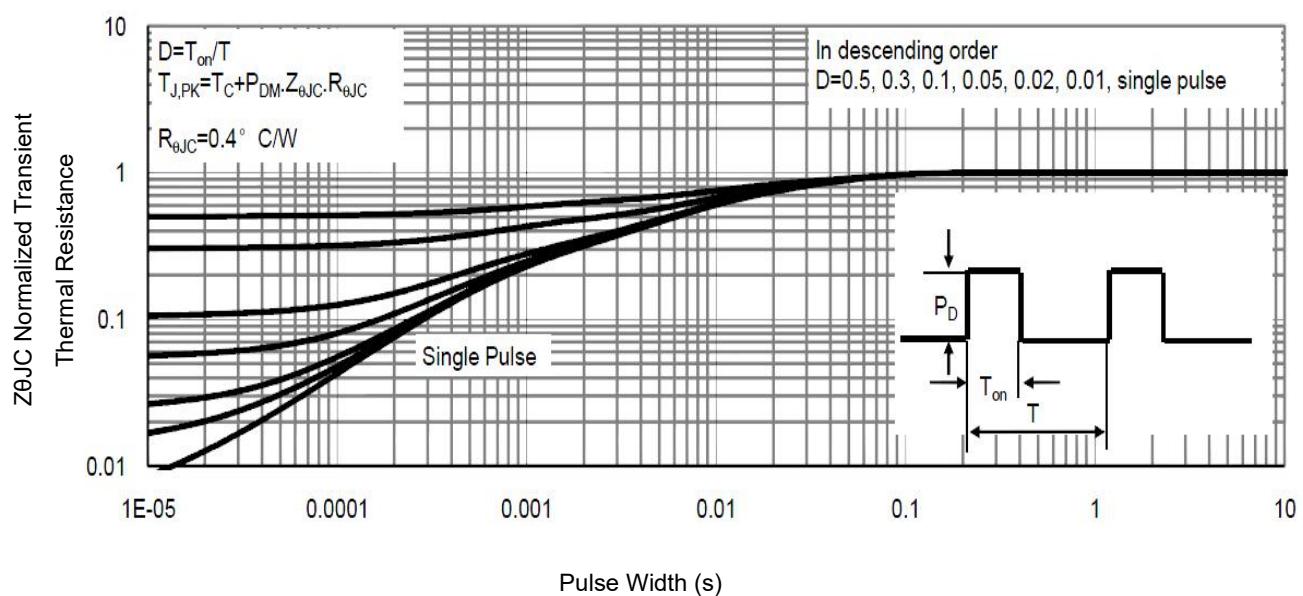


Fig9. Normalized Maximum Transient Thermal Impedance

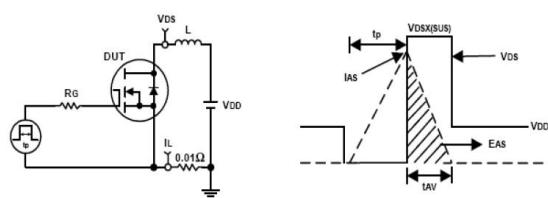


Fig10. Unclamped Inductive Test Circuit and waveforms

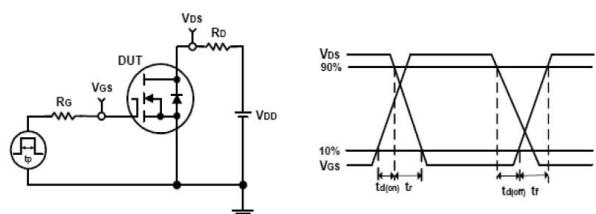
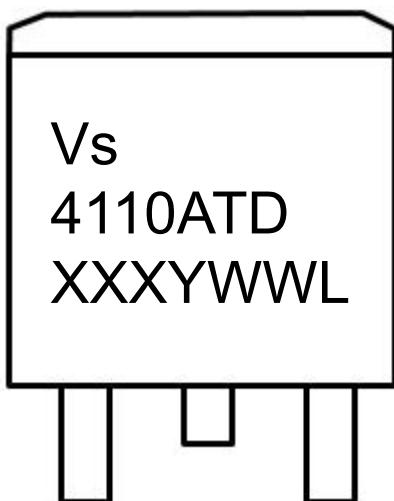


Fig11. Switching Time Test Circuit and waveforms

Marking Information



1st line: Vanguard Code (Vs)

2nd line: Part Number (4110ATD)

3rd line: Date code (XXXYYWW)

XXX: Wafer Lot Number Code , code changed with Lot Number

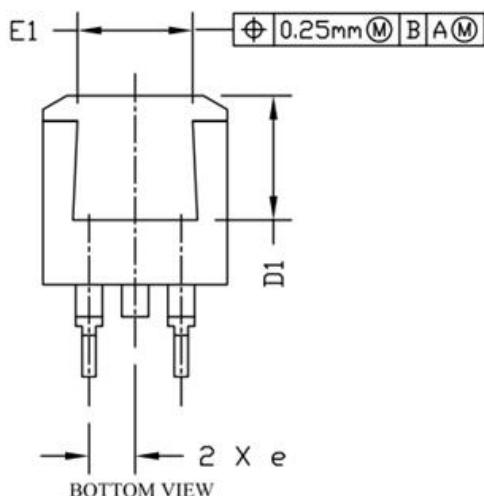
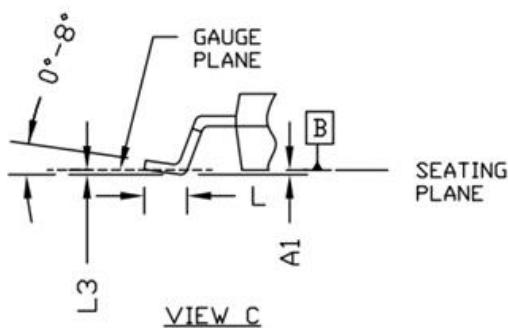
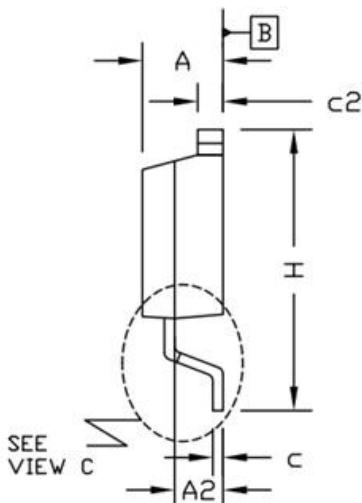
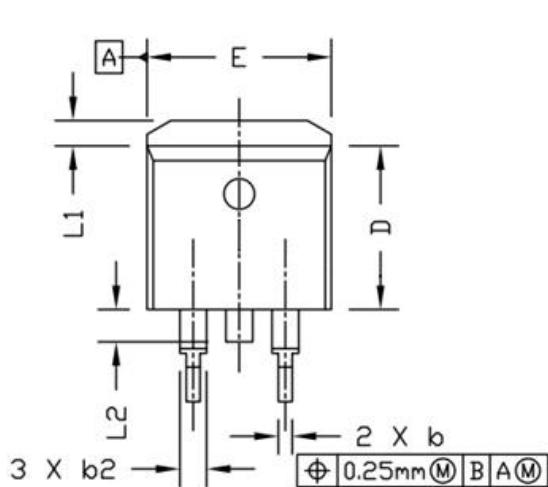
Y: Year Code, (e.g. E=2017, F=2018, G=2019, H=2020, etc)

WW: Week Code (01 to 53)

L: Class (A or B)



TO-263 Package Outline Data



Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	4.400	4.570	4.700
A1	0.000	0.100	0.200
A2	2.300	2.400	2.500
b	0.700	0.800	0.900
b2	1.200	1.270	1.360
c	0.381	0.500	0.737
c2	1.220	1.300	1.350
D	8.600	9.200	9.300
D1	6.860		
e	2.540 BSC		
E	9.780	9.880	10.260
E1	6.225		
H	14.700	15.100	15.500
L	2.000	2.550	2.750
L1	1.000	1.200	1.400
L2	1.300	1.600	1.700
L3	0.255 BSC		

Notes:

- Refer to JEDEC TO-263 variation AB
- Dimension "D" & "E" do NOT include mold flash, mold flash shall not exceed 0.127mm per side.

Customer Service

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